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## **RESISTOR, FIXED, CHIP, METAL FOIL**

## BASED ON TYPE SMR-PW, SMV-PW

ESCC Detail Specification No. 4001/028

| ssue 6 | November 2023 |
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### **DOCUMENTATION CHANGE NOTICE**

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| DCR No. | CHANGE DESCRIPTION                                     |
|---------|--|
| 1614    | Specification upissued to incorporate changes per DCR. |



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### 1 <u>GENERAL</u>

### 1.1 <u>SCOPE</u>

This specification details the ratings, physical and electrical characteristics and test and inspection data for the component type variants and/or the range of components specified below. It supplements the requirements of, and shall be read in conjunction with, the ESCC Generic Specification listed under Applicable Documents.

### 1.2 <u>APPLICABLE DOCUMENTS</u>

The following documents form part of this specification and shall be read in conjunction with it:

- (a) ESCC Generic Specification No. 4001.
- (b) A-QS-009, Isabellenhuette Test Procedure for Infrared Measurement.

### 1.3 <u>TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS</u> For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified

in ESCC Basic Specification No. 21300 shall apply.

### 1.4 THE ESCC COMPONENT NUMBER AND COMPONENT TYPE VARIANTS

1.4.1 <u>The ESCC Component Number</u>

The ESCC Component Number shall be constituted as follows:

Example: 4001028012R7D

- Detail Specification Reference: 4001028
- Component Type Variant Number: 01 (as required)
- Characteristic code: Resistance Value (2.7Ω): 2R7 (as required)
- Characteristic code: Resistance Tolerance (±0.5%): D (as required)

### 1.4.1.1 Characteristics and/or Ratings Codes

Characteristics and/or ratings to be codified as part of the ESCC Component Number shall be as follows:

(a) Resistance Value expressed by means of the following codes. The unit quantity shall be ohm ( $\Omega$ ):

| Resistance Value (Ω) | Code  |
|----------------------|-------|
| 0.00XX               | R00XX |
| 0.0XX                | R0XX  |
| 0.XX                 | RXX   |
| X.X                  | XRX   |

(b) Resistance Tolerance expressed by the following codes in accordance with ESCC Basic Specification No. 21700:

| Tolerance (± %) | Code Letter |
|-----------------|-------------|
| 0.5             | D           |
| 1               | F           |



### 1.5 <u>COMPONENT TYPE VARIANTS AND RANGE OF COMPONENTS</u>

The component type variants and range of components applicable to this specification are as follows:

| Variant<br>Number | Туре   | Style<br>(Note 1) |        | ce Range<br>R <sub>n</sub> | Tolerance<br>(± %)                    | Temperature<br>Coefficient TC | Value<br>Series | Weight<br>max |
|-------------------|--------|-------------------|--------|----------------------------|---------------------------------------|-------------------------------|-----------------|---------------|
|                   |        | . ,               | Min    | Max                        | , , , , , , , , , , , , , , , , , , , | (± 10 <sup>-6</sup> /K)       |                 | (g)           |
|                   |        |                   | (Ω)    | (Ω)                        |                                       |                               |                 |               |
| 01                | SMR-PW | 4723              | 0.01   | 4.7                        | 0.5, 1                                | Note 2                        | E12             | 0.6           |
|                   |        | (2 Terminal)      |        |                            |                                       |                               |                 |               |
| 02                | SMV-PW | 4723              | 0.0022 | 1                          | 0.5, 1                                | Note 2                        | E12             | 0.6           |
|                   |        | (4 Terminal)      |        |                            |                                       |                               |                 |               |

### NOTES:

- 1. See Para. 1.7.
- 2. Temperature Coefficient, TC, requirements:

| Variant<br>Number | Resistance<br>(Ω)        | Temperature<br>Coefficient<br>(10 <sup>-6</sup> /K) | Remarks                          |
|-------------------|--------------------------|---|----------------------------------|
| 01                | $0.01 \leq R_n \leq 4.7$ | -110, +0  | over $T_{amb}$ = -55°C to + 22°C |
|                   |                          | ±60   | over $T_{amb}$ = +22°C to +140°C |
|                   |                          | ±50   | over $T_{amb}$ = +22°C to +60°C  |
| 02                | $0.0022 \leq R_n \leq 1$ | -110, +0  | over $T_{amb}$ = -55°C to +22°C  |
|                   |                          | ±60   | over $T_{amb}$ = +22°C to +140°C |
|                   | $0.0022 \leq R_n < 0.01$ | ±50   | over $T_{amb}$ = +22°C to +60°C  |
|                   | $0.01 \leq R_n \leq 1$   | ±30   |                                  |

#### 1.6 MAXIMUM RATINGS

The maximum ratings shall not be exceeded at any time during use or storage.

Maximum ratings shall only be exceeded during testing to the extent specified in this specification and when stipulated in Test Methods and Procedures of the ESCC Generic Specification.

| Characteristics             | Symbols          | Limits                              | Units | Remarks          |
|-----------------------------|------------------|-------------------------------------|-------|------------------|
| Rated Dissipation           | Pn               | 3                                   | W     | Note 1           |
| Rated Voltage               | UR               | √(P <sub>n</sub> x R <sub>n</sub> ) | V     | Note 2           |
| Isolation Voltage           | U                | 1000                                | V     | -                |
| Operating Temperature Range | T <sub>op</sub>  | -55 to +140                         | °C    | T <sub>amb</sub> |
| Storage Temperature Range   | T <sub>stg</sub> | -55 to +140                         | °C    | -                |
| Soldering Temperature       | T <sub>sol</sub> | +260                                | °C    | Note 3           |

### NOTES:

- 1. At  $T_{amb} \le +80^{\circ}$ C. For  $T_{amb} > +80^{\circ}$ C, derate linearly to 0W at  $T_{amb} = +140^{\circ}$ C.
- 2.  $R_n$  = rated resistance.
- 3. Duration 5 seconds maximum.

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### 1.7 PHYSICAL DIMENSIONS

### 1.7.1 Variant 01 (2 Terminal Package)







| Symbols | Dimensions (mm) |      | Notes          |
|---------|-----------------|------|----------------|
|         | Min Max         |      |                |
| A       | 11.9            | 12.3 |                |
| В       | 3.2             | 3.6  |                |
| С       | 5.9             | 6.6  |                |
| D       | 1.5             | 2.5  | both terminals |
| E       | 0.3             | 0.5  | both terminals |
| F       | 4.9             | 5.3  | both terminals |



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## 1.7.2 Variant 02 (4 Terminal Package)



| Symbols | Dimensions (mm) |      | Notes                |
|---------|-----------------|------|----------------------|
|         | Min             | Max  | _                    |
| A       | 11.9            | 12.3 |                      |
| В       | 3.2             | 3.6  |                      |
| С       | 5.9             | 6.6  |                      |
| D       | 1.5             | 2.5  | both end terminals   |
| E       | 0.3             | 0.5  | both end terminals   |
| F       | 4.9             | 5.3  | both end terminals   |
| G       | 0.8             | 1.3  | both sense terminals |
| Н       | 4.3             | 4.9  |                      |
| J       | 0.3             | 0.5  | both sense terminals |
| К       | 8.8             | 9.6  |                      |
| L       | 0.85            | 1.45 | both sense terminals |



### 1.8 <u>FUNCTIONAL DIAGRAM</u>





### 1.9 MATERIALS AND FINISHES

### 1.9.1 <u>Terminals</u>

The terminal finish shall be electroplated tin-lead (with 30% to 80% tin; remainder lead) to a maximum thickness of  $70\mu m$ .

### 2 <u>REQUIREMENTS</u>

### 2.1 <u>GENERAL</u>

The complete requirements for procurement of the components specified herein are as stated in this specification and the ESCC Generic Specification. Permitted deviations from the Generic Specification, applicable to this specification only, are listed below.

Permitted deviations from the Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirement and do not affect the component's reliability, are listed in the appendices attached to this specification.

### 2.1.1 <u>Deviations from the Generic Specification</u>

### 2.1.1.1 Deviations from Production Control - Chart F2

- (a) Prior to body moulding, a 100% Infrared Measurement in accordance with A-QS-009 shall be performed on each resistor element:
  - Applied Voltage:  $\sqrt{(5P_n \times R_n)}$
  - Duration: 10ms



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### 2.1.1.2 Deviations from Screening Tests - Chart F3

(a) Screening Sub-lot Samples Selection, Mounting and Testing A quantity of 20 components shall be selected at random from the production lot and mounted in accordance with ESCC Generic Specification No. 4001 Para. 8.7. These mounted Screening Sub-lot samples shall be serialised and subjected to tests and inspections of Chart F3 in parallel with the 100% testing.

For each test requiring electrical measurements the results shall be recorded against component serial number. These samples shall not form part of the delivery lot.

(b) Microsection Examination

A quantity of 10 components selected at random from the production lot at the same time as the Screening Sub-lot samples, shall be subjected to microsection examination of internal solder joints. These samples shall not form part of the delivery lot. The following requirements shall apply:

- The 10 samples shall be prepared for microsection examination by individually mounting them in suitable epoxy filled moulds.
- Each sample shall be cut, polished and examined sequentially in several parallel planes. The planes shall be chosen such that:
  - All internal solder joints can be examined.
  - Each internal solder joint is cur perpendicular to the joint plane thereby facilitating the examination for any voids in the solder joint.
  - Each internal solder joint is sectioned and examined in 3 separate planes distributed along its length.
- Examination for any voids shall be performed for each solder joint in each of the 3 planes. Any voids identified in a solder joint in any of the 3 examinations, that total ≥ 50% of the visible solder joint area shall constitute a reject.
- A single reject shall be cause for production lot failure and the Manufacturer shall act in accordance with Lot Failure in ESCC Generic Specification No. 4001 Para. 4.3.3.
- Photographic results of all examinations traceable to the production lot, shall be included in the Screening Tests data documentation.
- (c) Para. 8.1 Overload

Overload shall only be performed on the mounted Screening Sub-lot samples. Resistance shall be measured as specified in Room Temperature Electrical Measurements both before and after Overload. Change in Resistance shall be calculated, recorded against component serial number, and shall not exceed the limit as follows:

- Change in Resistance during Overload: ±0.3% max
- (d) Para. 8.2, Non-Linearity: Not applicable.
- (e) Para. 8.3.2, Room Temperature Electrical Measurements For the testing of the mounted Screening Sub-lot samples, Resistance shall be recorded against component serial number both before and after Burn-in. Change in Resistance shall be calculated, recorded against component serial number, and shall not exceed the limit as follows:
  - Change in Resistance during Burn-in: ±0.2% max.





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### (f) Para. 8.4 Burn-in:

For the 100% Testing during Chart F3, burn-in in accordance with No-Bias Burn-in of this specification shall be performed with a duration of 24 (+24, -0) hours.

For the testing of the mounted Screening Sub-lot samples, burn-in in accordance with Biased Burn-in of this specification shall be performed with a duration of 168 (+24 -0) hours.

# (g) Para. 6.4 Check for Lot Failure 0 failures are allowed during all Chart F3 testing of the mounted Screening Sub-lot samples. In the event of any failure the lot shall be considered as failed.

### 2.1.1.3 Deviations from Qualification and Periodic Tests - Chart F4

(a) Para. 8.11, Robustness of Terminations: Not applicable.

### 2.1.1.4 Deviations from Data Documentation - Section 9

(a) Para. 9.6, Screening Tests Data: For each test performed on the mounted Screening Sub-lot samples requiring electrical measurements, the results shall be recorded against component serial number. Component drift calculations shall be recorded for each specified test against component serial number.

### 2.2 MARKING

The marking of all components delivered to this specification shall be in accordance with the requirements of ESCC Basic Specification No. 21700. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany each component in its primary package.

The information to be marked and the order of precedence, shall be as follows:

- (a) The ESCC qualified components symbol (for ESCC qualified components only).
- (b) The ESCC Component Number.
- (c) Traceability information.

#### 2.3 OVERLOAD

The test conditions for Overload, tested as specified in the ESCC Generic Specification, shall be as follows:

- Voltage:  $\sqrt{(5P_n \times R_n)}$
- Duration: 5s

#### 2.4 RESISTANCE TO SOLDERING HEAT

The test conditions for Resistance to Soldering Heat, tested as specified in the ESCC Generic Specification, shall be as follows:

- Temperature: 260°C
- Duration: 5 (+0 −1)s



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### 2.5 ELECTRICAL MEASUREMENTS AT ROOM, HIGH AND LOW TEMPERATURES

### 2.5.1 <u>Room Temperature Electrical Measurements</u>

The measurements shall be performed at  $T_{amb}$  = +22 ±3°C.

| Characteristics          | Symbols |                                   |       | Lin                  | Units                |    |
|--------------------------|---------|-----------------------------------|-------|----------------------|----------------------|----|
|                          |         | Conditions                        | (± %) | Min                  | Max                  |    |
| Resistance               | RA      | Para. 8.3.1.1                     | 0.5   | 0.995 R <sub>n</sub> | 1.005 R <sub>n</sub> | Ω  |
|                          |         |                                   | 1     | 0.99 R <sub>n</sub>  | 1.01 R <sub>n</sub>  |    |
| Insulation<br>Resistance | Rı      | Para. 8.3.1.2<br>V = 500V, Note 1 | All   | 1000                 | -                    | MΩ |

### NOTES:

1. Guaranteed but not tested during Screening Tests.

### 2.5.2 High and Low Temperatures Electrical Measurements

| Characteristics             | Symbols ESCC 4001 Test |                                    | Limits |        | Units |
|-----------------------------|------------------------|------------------------------------|--------|--------|-------|
|                             |                        | Method and<br>Conditions           | Min    | Max    |       |
| Resistance Change between   | $\Delta R_A/R_A$       | Para. 8.3.1.1 Note 1               |        |        | %     |
| -55 (+3 -0)°C and +22 ±3°C  |                        | TC = -110/+0 x10 <sup>-6</sup> /K: | -0.88  | +0     |       |
| Resistance Change between   | $\Delta R_A/R_A$       | Para. 8.3.1.1 Note 1               |        |        | %     |
| +140 (+0 -3)°C and +22 ±3°C |                        | TC = ±60 x10 <sup>-6</sup> /K:     | -0.726 | +0.726 |       |
| Resistance Change between   | $\Delta R_A/R_A$       | Para. 8.3.1.1 Note 2               |        |        | %     |
| +60 ±3°C and +22 ±3°C       |                        | TC = ±30 x10 <sup>-6</sup> /K:     | -0.132 | +0.132 |       |
|                             |                        | TC = ±50 x10 <sup>-6</sup> /K:     | -0.22  | +0.22  |       |

### NOTES:

- 1. The measurements shall be performed on all the mounted Screening Sub-lot samples.
- 2. The measurements shall be performed on a sample of 5 components selected from the total production lot.

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#### 2.6 INTERMEDIATE AND END-POINT ELECTRICAL MEASUREMENTS

The components shall be mounted as specified in the ESCC Generic Specification.

Unless otherwise specified, the measurements shall be performed at  $T_{amb}$  = +22 ±3°C.

Unless otherwise specified the test methods and test conditions shall be as per the corresponding test defined in Para. 2.5.1 Room Temperature Electrical Measurements.

| Test Reference per ESCC No.               | Characteristics           | Symbols Limits   |               | its | Units |
|---|---------------------------|------------------|---------------|-----|-------|
| 4001                                      |                           |                  | Min           | Max |       |
| Rapid Change of Temperature               |                           |                  |               |     |       |
| Initial Measurement                       | Resistance                | RA               | Record Values |     |       |
| Final Measurement                         | Change in Resistance      | $\Delta R_A/R_A$ | ±0.2          |     | %     |
| Vibration                                 |                           |                  |               |     |       |
| Initial Measurement                       | Resistance                | RA               | Record Values |     |       |
| Final Measurement                         | Change in Resistance      | $\Delta R_A/R_A$ | ±0.2          |     | %     |
| Resistance to Soldering Heat              |                           |                  |               |     |       |
| Initial Measurement                       | Resistance                | R <sub>A</sub>   | Record Values |     |       |
| Final Measurement                         | Change in Resistance      | $\Delta R_A/R_A$ | ±0.3          |     | %     |
| Solderability                             |                           |                  |               |     |       |
| Initial Measurement                       | Resistance                | RA               | Record Values |     |       |
| Final Measurement                         | Change in Resistance      | $\Delta R_A/R_A$ | ±0.2          |     | %     |
| Climatic Sequence                         |                           |                  |               |     |       |
| Initial Measurements<br>(Procedure 1)     | Resistance (after drying) | RA               | Record Values |     |       |
| Final Measurements                        | Change in Resistance      | $\Delta R_A/R_A$ | ±0.           | .3  | %     |
|   | Insulation Resistance     | Ri               | 1000          | -   | MΩ    |
| Operating Life                            |                           |                  | •             |     |       |
| Initial Measurement                       | Resistance                | R <sub>A</sub>   | Record Values |     |       |
| (0 hour)                                  |                           |                  |               |     |       |
| Intermediate Measurements<br>(1000 hours) | Change in Resistance      | $\Delta R_A/R_A$ | ±0.2          |     | %     |
| Final Measurements                        | Change in Resistance      | $\Delta R_A/R_A$ | ±0.2          |     | %     |
| (2000 hours)                              | Insulation Resistance     | Rı               | 1000          | -   | MΩ    |





### 2.7 BURN-IN CONDITIONS

### 2.7.1 No-Bias Burn-in Conditions for 100% Testing

| Characteristics     | Symbols          | Conditions (Note 1) | Units |
|---------------------|------------------|---------------------|-------|
| Ambient Temperature | T <sub>amb</sub> | +140 (+0 -5)        | °C    |
| Test Voltage        | VT               | No Bias             | V     |

#### NOTES:

- 1. No-Bias Burn-in (High Temperature Bake) shall be performed on components that are not mounted.
- 2. No-Bias Burn-in duration shall be 24 (+24 -0) hours.
- 3. After Burn-in, the components shall be removed from the chamber and allowed to cool under normal atmospheric conditions for a minimum of 1 hour. They shall then be visually examined. There shall be no evidence of damage and marking shall still be legible.

### 2.7.2 Biased Burn-in Conditions for Screening Sub-lot Samples

| Characteristics      | Symbols           | Conditions (Note 1)       | Units |
|----------------------|-------------------|---------------------------|-------|
| Terminal Temperature | T <sub>term</sub> | +80 (+0 -3)               | °C    |
| Test Voltage         | VT                | $\sqrt{(P_n \times R_n)}$ | V     |

### NOTES:

- 1. Biased Burn-in shall be performed on the applicable sample components that are mounted in accordance with ESCC Generic Specification No. 4001 Para. 8.7.
- 2. Biased Burn-in duration shall be 168 (+24 -0) hours.
- 3. After Burn-in, the components shall be removed from the chamber and allowed to cool under normal atmospheric conditions for a minimum of 1 hour. They shall then be visually examined. There shall be no evidence of damage and marking shall still be legible.

#### 2.8 OPERATING LIFE CONDITIONS

The conditions shall be as specified in Para. 2.7.2 for Biased Burn-in.

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## APPENDIX A

### AGREED DEVIATIONS FOR ISABELLENHUETTE (D)

| Items Affected  | Description of Deviations   |  |   |
|---|---|--|---|
| Para. 2.1.1.1 Deviations from   | Para. 5.2.1, Dimension Check:   |  |   |
| Generic Specification:  | A 100% inspection may be performed.   |  |   |
| Production Control - Chart F2   |   |  |   |
| Para. 2.1.1.2 Deviations from<br>Generic Specification:<br>Screening Tests - Chart F3 | -   | ia of Para. 8.6,   | ntified during visual examination<br>as below, shall not be considered  |
|   | No. 2054000 shall apply<br>Para. 3.1, Magnif  | cific requiremen<br>y with the follow<br>fication: All ite | ts of ESCC Basic Specification<br>ring deviations:<br>ems shall be examined with a<br>nagnification of between 5 and 20 |
|   | • Paras. 4.4(b) & 4.4(  | (c): These rejec   | t criteria are not applicable.  |
|   | •   | rial showing ho<br>3% of the total                         | as follows:<br>les or cracks whose total surface<br>surface area of the moulding or                                     |
|   | <ul> <li>Any holes or cra<br/>between any 2</li> </ul>  |  | lding material that bridge the space  |
| Para. 2.1.1.3 Deviations from   | Para. 8.6, External Visual Inspection: As for Screening Tests above.Paras. 8.8, 8.9, 8.11 & 8.12, Rapid Change of Temperature, Vibration,   |  |   |
| Generic Specification:  |   |  |   |
| Qualification and Periodic Tests -<br>Chart F4  | Robustness of Terminations & Resistance to Soldering Heat:  |  |   |
|   | For Variant 02, any holes or cracks identified during visual examination<br>that do not fail the criteria of Para. 8.6, as above, shall not be considered<br>as evidence of damage. |  |   |
|   | Para. 8.8, Rapid Change of Temperature:   |  |   |
|   | A high temperature extreme of $T_{amb}$ = +150 (+0 -3)°C may be applied during testing.   |  |   |
|   | Para. 8.10, Climatic Sequence:  |  |   |
|   | Para. 8.10.5, Low Air Pressure: Not applicable.   |  |   |
|   | Para. 8.10.7, DC Load: Not applicable.  |  |   |
|   | Para. 8.15, Permanence of Marking: Not applicable.  |  |   |
| Para. 1.4.1.1 Characteristics Codes:<br>Resistance Value                              |   | •  | y means of the following codes<br>The unit quantity shall be ohm ( $\Omega$ ):  |
|   | Resistance Value ( $\Omega$ )   | Code   | ]   |
|   | 0.00XX  | R00XX  |   |
|   | -   |  | 4   |
|   | 0.0XX   | R0XX   |   |
|   | 0.0XX<br>0.XXX  | R0XX<br>RXXX   |   |



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| Items Affected  | Description of Deviations  |  |
|---|--|--|
| Para. 1.5 Component Type Variants and Range of Components         | For all Variants, additional resistance values, Rn, from within the specified Resistance Range, but outside of the specified Value Series, are available upon request from Isabellenhuette.  |  |
| Para. 2.2 Marking:<br>Marking of Tolerance on Resistance<br>Value | The tolerance on resistance value may be marked using the actual numeric value (0.5% or 1%) instead of the specified code letter.  |  |
| Para. 2.2 Marking:<br>Marking of Traceability Information         | <ul> <li>The manufacturing date code may be marked using a three-digit code where:</li> <li>the first digit is a letter to indicate the year of manufacture in accordance with the first digit of the two-character code for year and</li> </ul>                             |  |
|   | <ul> <li>month in a twenty-year cycle in IEC Publication No. 60062.</li> <li>the last two digits indicate the week of the year (i.e. 01 to 52) during which encapsulation or the final production process occurred.</li> <li>For example: R41 for week 41 of 2023</li> </ul> |  |